## Applicant(s)/Patent Under Application/Control No. Reexamination 10/684,874 AGA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2823 Michelle Estrada **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code MM-YYYY 09-2003 438/695 US-6,613,678 Sakaguchi et al. Α 257/347 US-5,834,812 11-1998 Golland et al. В 05-2002 Usenko et al. 438/120 US-6,387,829 С 438/459 02-2001 D US-6,191,007 Matsui et al. US-Ε F US-G US-Н US-US-US-J US-K US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY EP 1302985 A1 04-2003 **European Patent** NAKANO et al. H01L 27/12 Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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